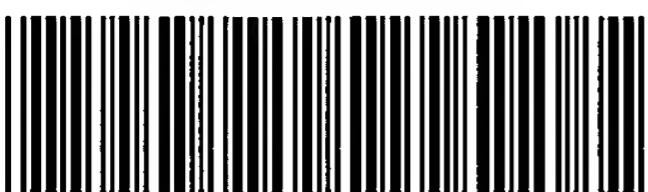


## **Search Notes**



**Application/Control No.**

10/790,803

---

**Examiner**

Alain L. Bashore

**Applicant(s)/Patent under  
Reexamination**

TANAHASHI ET AL.

## Art Unit

1762

**SEARCHED**

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
427	599;598	9/17/2006	AB
427	128	9/17/2006	AB
428	694TM 694	9/17/2006	AB
428/900,65.3,65.7		9/17/2006	ab